





Test Report No.: W7L-P23030011RI04

VARIANT IC TEST REPORT (RSS-130)

Applicant:	Particle Industries,Inc		
Address:	325 9th Street, San Francisco, CA 94103, United States Of America		
Manufacturer or Supplier:	Particle Industries,Inc		
Address:	325 9th Street, San Francisco, CA	94103, United States Of America	
Product:	E Series Module		
Brand Name:	Particle		
Model Name:	E404X		
IC:	20127-E404X		
Date of tests:	Mar. 10, 2023 ~ Mar. 24, 2023		
The tests have bee	The tests have been carried out according to the requirements of the following standard:		
 \subseteq RSS-130 Issue 2, February, 2019 \subseteq RSS-Gen Issue 5, Amendment 1, March 2019 \subseteq ANSI C63.26-2015 			
CONCLUSION: The submitted sample was found to COMPLY with the test requirement			
Prepared by Simon Wang Engineer / Mobile Department Approved by Luke Lu Manager / Mobile Department			
Simon Wang		luke lu	
	ate: Mar. 24, 2023 corporates by reference, the Conditions of Testing as posted at the	Date: Mar. 24, 2023	
http://www.bureauveritas.com/hom		ntended for your exclusive use. Any copying or replication of this report to or for any other person or	

This report is governed by, and incorporates by reference, the Conditions of Testing as posted at the date of issuance of this report at http://www.bureauveritas.com/home/about-us/our-business/cps/about-us/hems-conditions/ and is intended for your exclusive use. Any copying or replication of this report to or for any other person or entity, or use of our name or trademark, is permitted only with our prior written permission. This report sets forth our findings solely with respect to the test samples identified herein. The results set forth in this report are not indicative or representative of the quality or characteristics of the lot from which a test sample was taken or any similar or identical product unless specifically and expressly noted. Our report includes all of the tests requested by you and the results thereof based upon the information that you provided to us. Measurement uncertainty is only provided upon request for accredited tests. Statements of conformity are based on simple acceptance criteria without taking measurement uncertainty into account, unless otherwise requested in writing. You have 60 days from date of issuance of this report to notify us of any material error or omission caused by our negligence or if you require measurement uncertainty; provided, however, that such notice shall be in writing and shall specifically address the issue you wish to raise. A failure to raise such issue within the prescribed time shall constitute your unqualified acceptance of the completeness of this report, the tests conducted and the correctness of the report condents.



TABLE OF CONTENTS

F	RELEA	SE CONTROL RECORD	3
1	I SU	IMMARY OF TEST RESULTS	4
2	2 GE	ENERAL INFORMATION	5
	2.1		
		GENERAL DESCRIPTION OF APPLIED STANDARDS	
	2.3	TRANSMIT ANTENNA	7
3	3 INF	FORMATION ON THE TESTING LABORATORIES	8
,	1 MC	ODIEICATIONS DECORDEDS FOR ENGINEERING CHANGES TO THE FLIT BY	THE LAB O

Tel: +86 755 8869 6566 Fax: +86 755 8869 6577

Email: <u>customerservice.sw@bureauveritas.con</u>



RELEASE CONTROL RECORD

ISSUE NO. REASON FOR CHANGE		DATE ISSUED
W7L-P22110028RI04 Original release		Dec. 08, 2022
W7L-P23030011RI04	Based on the original product change components and hardware version, it doesn't affect RF Function, The new sample no change data.	Mar. 24, 2023

Tel: +86 755 8869 6566 Fax: +86 755 8869 6577

Email: <u>customerservice.sw@bureauveritas.con</u>



1 SUMMARY OF TEST RESULTS

The EUT has been tested according to the following specifications:

APPLIED STANDARD: IC RSS-130, RSS-Gen		
STANDARD SECTION RSS-Gen	TEST TYPE AND LIMIT	RESULT
6.7	Occupied Bandwidth	See Note
6.8	Transmit antenna	See Note
STANDARD SECTION RSS-130	TEST TYPE AND LIMIT	RESULT
4.5	Frequency Stability AFC Freq. Error vs. Voltage AFC Freq. Error vs. Temperature	See Note
4.6	Maximum Peak Output Power	See Note
4.6	peak-to-average power ratio	See Note
4.7	Band Edge Measurements	See Note
4.7	Conducted Spurious Emissions	See Note
4.7	Radiated Spurious Emissions	See Note

NOTE: Please refer to the original report W7L-P22110028EM02, IC: 20127-E404X.

Tel: +86 755 8869 6566

Fax: +86 755 8869 6577

2 GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF EUT

EUT	E Series Module	
BRAND NAME	Particle	
MODEL NAME	E404X	
POWER SUPPLY	5.0Vdc(adapter or host equipment) 3.8Vdc (Li-ion, battery)	
MODULATION TECHNOLOGY	LTE	QPSK, 16QAM
	LTE Band 12 Channel Bandwidth: 1.4MHz	699.7MHz ~ 715.3MHz
	LTE Band 12 Channel Bandwidth: 3MHz	700.5MHz ~ 714.5MHz
FREQUENCY RANGE	LTE Band 12 Channel Bandwidth: 5MHz	701.5MHz ~ 713.5MHz
TREGUENCT RANGE	LTE Band 12 Channel Bandwidth: 10MHz	704.0MHz ~ 711.0MHz
	LTE Band 13 Channel Bandwidth: 5MHz	779.5MHZ ~ 784.5MHZ
	LTE Band 13 Channel Bandwidth: 10MHz	782.0MHZ
	LTE Band 12	QPSK: 1M14G7D
	Channel Bandwidth: 1.4MHz	16QAM: 968KW7D
	LTE Band 12 Channel Bandwidth: 3MHz	QPSK: 1M14G7D
		16QAM: 968KW7D
	LTE Band 12 Channel Bandwidth: 5MHz	QPSK: 1M14G7D
EMISSION DESIGNATOR		16QAM: 968KW7D
	LTE Band 12 Channel Bandwidth: 10MHz	QPSK: 1M14G7D
		16QAM: 968KW7D
	LTE Band 13 Channel Bandwidth: 5MHz	QPSK: 1M13G7D
		16QAM: 968KW7D
	LTE Band 13	QPSK: 1M13G7D
	Channel Bandwidth: 10MHz	16QAM: 968KW7D



Test Report No.: W7L-P23030011RI04

	I	·	
	LTE Band 12	175.79mW	
	Channel Bandwidth: 1.4MHz		
	LTE Band 12	172.98mW	
	Channel Bandwidth: 3MHz	172.90111	
	LTE Band 12	172.98mW	
MAX. ERP/EIRP	Channel Bandwidth: 5MHz	172.9011100	
POWER	LTE Band 12	176.20mW	
	Channel Bandwidth: 10MHz	176.2011100	
	LTE Band 13	402.20mW	
	Channel Bandwidth: 5MHz	193.20mW	
	LTE Band 13	402 C4mW	
	Channel Bandwidth: 10MHz	193.64mW	
	External Antenna(KIT) with 2.46 gain for LTE12		
ANTENNA TYPE	External Antenna(KIT) with 2.46gain for LTE13		
ANTENNA ITPE	External Antenna(Taoglas) with 1gain for LTE12		
	External Antenna(Taoglas) with 1gain for LTE13		
HW VERSION	v1.0.0		
SW VERSION	V4.0.0		
I/O PORTS	Refer to user's manual		
CABLE SUPPLIED	N/A		
EXTREME			
TEMPERATURE	-40-75 °C		
	0.01/		
EXTREME VOLTAGE	3.3V – 4.3V		

NOTE:

- 1. For a more detailed features description, please refer to the manufacturer's specifications or the user's manual.
- 2. The EUT incorporates a SISO function. Physically, the EUT provides one completed transmitter and one receiver.

MODULATION MODE	TX FUNCTION	
LTE	1TX/1RX	

- 3. For the test results, the EUT had been tested with all conditions. But only the worst case was shown in test report.
- 4. Sample Information:

Sample Number	Description
Sample 1	Main test Sample(U11:TI - bq24195, U12:Richtek -RT5760CHGH6F)
Sample 2	Based on Sample 1 changed U11 to TI - bq24190
Sample 3	Based on Sample 1 changed U12 to TI - TLV62568
Sample 4	Based on Sample 1 changed U12 to MPS - MP1601GTF-Z

Note: Full testing was performed by sample 1, other samples verified the worst case of RSE, Only the worst case data(Sample 1) was reported.

Page 6 of 9

2.2 GENERAL DESCRIPTION OF APPLIED STANDARDS

The EUT is a RF product. According to the specifications of the manufacturer, it must comply with the requirements of the following standards:

Canada RSS-130, Issue 2, February 2019 Canada RSS-Gen, Issue 5, Amendment 1, March 2019 ANSI C63.26 - 2015

NOTE: All test items have been performed and recorded as per the above standards.

2.3 TRANSMIT ANTENNA

The applicant for equipment certification shall provide a list of all antenna types that may be used with the transmitter, where applicable (i.e. for transmitters with detachable antenna), indicating the maximum permissible antenna gain (in dBi) and the required impedance for each antenna. The test report shall demonstrate the compliance of the transmitter with the limit for maximum equivalent isotropically radiated power (e.i.r.p.) specified in the applicable RSS, when the transmitter is equipped with any antenna type, selected from this list.

Antenna Type	External Antenna(KIT)/ External Antenna(Taoglas)
Antenna Gain	External Antenna(KIT) 2.46dBi gain for LTE B12
	External Antenna(KIT) 2.46dBi gain for LTE B13
	External Antenna(Taoglas) Antenna 1dBi gain for LTE B12
	External Antenna(Taoglas) Antenna 1dBi gain for LTE B13
Impedance	50 Ω

Page 7 of 9

BV 7Layers Communications Technology



3 INFORMATION ON THE TESTING LABORATORIES

We, BV 7Layers Communications Technology (Shenzhen) Co. Ltd, were founded in 2015 to provide our best service in EMC, Radio, and Telecom. Our laboratories are accredited and approved according to ISO/IEC 17025.

If you have any comments, please feel free to contact us at the following:

Shenzhen EMC/RF Lab:

Tel: +86 755 8869 6566 Fax: +86 755 8869 6577

Email: <u>customerservice.sw@bureauveritas.com</u>

Web Site: www.adt.com.tw

The address and road map of all our labs can be found in our web site also.

Fax: +86 755 8869 6577
Email: customerservice.sw@bureauveritas.com

Tel: +86 755 8869 6566



4 MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE EUT BY THE LAB

No modifications were made to the EUT by the lab during the test.

---END----

Tel: +86 755 8869 6566 Fax: +86 755 8869 6577

Email: customerservice.sw@bureauveritas.com